

**Notice of References Cited**

Application/Control No.

09/225,687

Applicant(s)/Patent Under  
Reexamination  
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Examiner

Susy N Tsang-Foster

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	Luggenholscher et al. "Investigations on Electric Field Distributions in a Microwave Discharge in Hydrogen", obtained from <URL: <a href="http://www.phys.tue.nl/FLTPD/Luggenhoelscher.pdf">http://www.phys.tue.nl/FLTPD/Luggenhoelscher.pdf</a> >.
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